## Notice of References Cited 10/002,356 Examiner Ba Huynh Reexamination SEAMAN ET AL. Art Unit Page 1 of 1

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0085913	05-2003	Ahmad et al.	345/730
	В	US-2003/0052897	03-2003	Lin, Shu	345/619
	С	US-6,574,419	06-2003	Nonomura et al.	386/95
	D	US-6,353,702	03-2002	Ando et al.	386/95
	Е	US-2004/0013403	01-2004	Asada et al.	386/52
	F	US-			
	G	US-			
	Η	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				1000	
	Q					
	R					
	S				4	
	Т					

## **NON-PATENT DOCUMENTS**

	NOW THE BOOMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	x	BEST AVAILABLE COPY				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under